# Parameters Estimators for the Generalized Exponential Distribution

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Abstract. Maximum likelihood method is utilized to estimate the two parameters of generalized exponential distribution based on grouped and censored data. This method does not give closed form for the estimates, thus numerical procedure is used. Reliability measures for the generalized exponential distribution are calculated. Testing the goodness of fit for the exponential distribution against the generalized exponential distribution is discussed. Relevant reliability measures of the generalized exponential distributions are also evaluated. A set of real data is employed to illustrate the results given in this paper.

**Key Words:** Lifetime data, censored data, point estimate, interval estimate, maximum likelihood estimate.

#### ACRONYMS

$\operatorname{cdf}$	cumulative distribution function
$\operatorname{pdf}$	probability density function
sf	survival function
MLE	maximum likelihood estimate
C.I.	confidence interval
$\mathrm{GED}(\alpha,\beta)$	generalized exponential distribution with parameters $\alpha, \beta$
$\mathrm{ED}(lpha)$	exponential distribution with parameter $\alpha$
MTTF	mean time to failure

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## 1. INTRODUCTION

Tests, in reliability analysis, can be performed for units or systems either continuously or intermittently inspection for failure. If the life test can be based on continuous inspection throughout the experiment, then the sample life lengths, i.e. data, is said to be complete. In other hand, the data from intermittent inspections are known by grouped data. The number of failures expresses this data in each inspection interval is used more frequently than the first one, since it, generally, costs less and requires fewer efforts. Moreover, intermittent inspections is some times the only possible or available for units or their system, Ehrenfeld (1962).

It is known that the exponential distribution,  $GE(\alpha)$ , is the most frequently used distribution in reliability theory and applications. The mean and its confidence limit of this distribution have been estimated based on group and censored data by Seo and Yum(1993) and Chen and Mi (1996), respectively.

Recently the generalized exponential distribution  $GED(\alpha, \beta)$  is introduced and studied quite extensively by Gupta and Kundu in a series of papers from (1999) to (2003) and Sarhan (2007). The cdf of  $GED(\alpha, \beta)$  takes the following form

$$F(x; \alpha, \beta) = (1 - \exp\{-\alpha x\})^{\beta}, \quad x > 0, \alpha, \beta > 0.$$
 (1.1)

The corresponding sf is

$$\bar{F}(x;\alpha,\beta) = 1 - (1 - \exp\{-\alpha x\})^{\beta},$$
 (1.2)

the pdf is

$$f(x; \alpha, \beta) = \alpha \beta \exp\{-\alpha x\} \left(1 - \exp\{-\alpha x\}\right)^{\beta - 1}, \tag{1.3}$$

the hazard rate function is

$$h(x;\alpha,\beta) = \frac{\alpha\beta \exp\{-\alpha x\} \left(1 - \exp\{-\alpha x\}\right)^{\beta - 1}}{1 - \left(1 - \exp\{-\alpha x\}\right)^{\beta}},\tag{1.4}$$

and the MTTF is

$$MTTF = \sum_{i=1}^{\infty} {\beta \choose i} \frac{(-1)^{i+1}}{i\alpha}.$$
 (1.5)

Here  $\alpha$  is the scale parameter and  $\beta$  is the shape parameter. As it seems  $GED(\alpha, \beta)$  reduces to  $ED(\alpha)$  when the shape parameter  $\beta$  equals 1. The  $GED(\alpha, \beta)$  can have increasing and decreasing hazard rates depending on the shape parameter  $\beta$ . The hazard rate increase from 0 to  $\alpha$  if  $\beta > 1$  and if  $\beta < 1$  it decreases from  $\infty$  to  $\alpha$ . This property leads to a good ability of using this distribution in reliability and life testing.

The main objective in this paper is to derive the MLE of the parameters of the  $GED(\alpha, \beta)$ , when the data are grouped and censored. The paper gives some reliability measures for the GED. At this situation, it is known that MLE does not

give closed form, but iterative procedure can be used to give the required results. In fact numerical iterative procedure has been used for the GE by Ehrenfeld (1962) and Nelson (1977) among many others.

The rest of the paper is organized as follows. In section 2, we present the notations and assumptions used throughout this paper. Point and interval estimations of the unknown parameters are discussed in section 3. Testing for the goodness of fit of ED against the GED based on the estimated likelihood ratio test statistics is discussed in section 4. A set of real data is applied and a conclusion is drawn in section 5.

## 2. MODEL AND ASSUMPTIONS

Assumptions:

- 1. *n* independent and identical experimental units are put on a life test at time zero.
- 2. The lifetime of each unit follows a GED( $\alpha, \beta$ ) with cdf given by (1.1).
- 3. The inspection times  $0 < t_1 < t_2 < \cdots < t_k < \infty$  are predetermined.
- 4. The test is terminated at the predetermined time  $t_k$ . That is, the data is of Type-I censoring.
- 5.  $t_0 = 0$  and  $t_{k+1} = \infty$ .
- 6. The number of failures in  $(t_i, t_{i+1}]$  are recorded.

The data collected from the above test scheme consist of number of failures  $n_i$  in the interval  $(t_{i-1}, t_i]$ , i = 1, 2, ...k and the number of units tested without failing up to  $t_k$ ,  $n_{k+1}$  (censored units).

# 3. PARAMETER ESTIMATION

Based on the data collected in the previous section, the likelihood function takes the following form

$$L = C \prod_{i=1}^{k} \left[ P\{t_{i-1} < T \le t_i\} \right]^{n_i} \left[ P\{T > t_k\} \right]^{n_{k+1}}$$
 (3.1)

where  $C = \frac{n!}{\prod_{\ell=1}^{k+1} n_{\ell}!}$  is a constant with respect to the parameters  $\alpha$  and  $\beta$ .

But

$$P\{t_{i-1} < T < t_i\} = F(t_i) - F(t_{i-1}),$$

and

$$P\{T > t_k\} = 1 - F(t_k)$$
.

Then based on assumption 2, we have

$$L = C \left[ 1 - \left( 1 - e^{-\alpha t_k} \right)^{\beta} \right]^{n_{k+1}} \prod_{i=1}^k \left[ \left( 1 - e^{-\alpha t_i} \right)^{\beta} - \left( 1 - e^{-\alpha t_{i-1}} \right)^{\beta} \right]^{n_i}$$
(3.2)

The log-likelihood function becomes

$$\mathcal{L} = \ln C + n_{k+1} \ln \left[ 1 - \left( 1 - e^{-\alpha t_k} \right)^{\beta} \right] + \sum_{i=1}^{k} n_i \ln \left\{ \left[ \left( 1 - e^{-\alpha t_i} \right)^{\beta} - \left( 1 - e^{-\alpha t_{i-1}} \right)^{\beta} \right] \right\},$$
(3.3)

The partial derivatives of  $\mathcal{L}$  are

$$\frac{\partial \mathcal{L}}{\partial \alpha} = -\frac{t_k n_{k+1} \beta e^{-\alpha t_k} \left(1 - e^{-\alpha t_k}\right)^{\beta - 1}}{1 - \left(1 - e^{-\alpha t_k}\right)^{\beta}} \\ + \beta \sum_{i=1}^k \frac{n_i \left[t_i e^{-\alpha t_i} \left(1 - e^{-\alpha t_i}\right)^{\beta - 1} - t_{i-1} e^{-\alpha t_{i-1}} \left(1 - e^{-\alpha t_{i-1}}\right)^{\beta - 1}\right]}{\left(1 - e^{-\alpha t_i}\right)^{\beta} - \left(1 - e^{-\alpha t_{i-1}}\right)^{\beta}}, \\ \frac{\partial \mathcal{L}}{\partial \beta} = -\frac{n_{k+1} \left(1 - e^{-\alpha t_k}\right)^{\beta} \ln \left(1 - e^{-\alpha t_k}\right)}{1 - \left(1 - e^{-\alpha t_k}\right)^{\beta}} + \frac{n_1 \left(1 - e^{-\alpha t_1}\right)^{\beta} \ln \left(1 - e^{-\alpha t_1}\right)}{\left(1 - e^{-\alpha t_i}\right)^{\beta}} \\ + \sum_{i=2}^k \frac{n_i \left[\left(1 - e^{-\alpha t_i}\right)^{\beta} \ln \left(1 - e^{-\alpha t_i}\right) - \left(1 - e^{-\alpha t_{i-1}}\right)^{\beta} \ln \left(1 - e^{-\alpha t_{i-1}}\right)\right]}{\left(1 - e^{-\alpha t_i}\right)^{\beta} - \left(1 - e^{-\alpha t_{i-1}}\right)^{\beta}}.$$

Setting  $\frac{\partial \mathcal{L}}{\partial \alpha} = 0$  and  $\frac{\partial \mathcal{L}}{\partial \beta} = 0$ , we get the likelihood equations, which should be solved to get the MLE of the parameters  $\alpha$  and  $\beta$ . As it seems the likelihood equations have no closed form solutions in  $\alpha$  and  $\beta$ . Therefore a numerical technique method should be used to get the solution.

Asymptotic confidence bounds: Since the MLE of the element of the vector of unknown parameters  $\theta = (\alpha, \beta)$ , are not obtained in closed forms, then it is not possible to derive the exact distributions of the MLE of these parameters. Thus we derive approximate confidence intervals of the parameters based on the asymptotic distributions of the MLE of the parameters. It is known that the asymptotic distribution of the MLE  $\hat{\theta}$  is given by, see Miller (1981),

$$\left( (\hat{\alpha} - \alpha), (\hat{\beta} - \beta) \right) \to N_2 \left( 0, \mathbf{I}^{-1}(\alpha, \beta) \right) \tag{3.4}$$

where  $\mathbf{I^{-1}}(\alpha,\beta)$  is the variance covariance matrix of the unknown parameters  $\theta = (\alpha,\beta)$ . The elements of the  $2 \times 2$  matrix  $\mathbf{I^{-1}}$ ,  $I_{ij}(\alpha,\beta)$ , i,j=1,2, can be approximated by  $I_{ij}(\hat{\alpha},\hat{\beta})$ , where

$$I_{ij}(\hat{\theta}) = -\left. \frac{\partial^2 \mathcal{L}(\theta)}{\partial \theta_i \partial \theta_j} \right|_{\theta = \hat{\theta}} \tag{3.5}$$

From (3.3), we get the following

$$\frac{\partial^2 \mathcal{L}}{\partial \alpha^2} = \sum_{i=1}^{k+1} n_i \frac{P_i P_{i, \alpha^2} - [P_{i, \alpha}]^2}{P_i^2} , \qquad (3.6)$$

$$\frac{\partial^2 \mathcal{L}}{\partial \beta^2} = \sum_{i=1}^{k+1} n_i \frac{P_i P_{i,\beta^2} - [P_{i,\beta}]^2}{P_i^2} , \qquad (3.7)$$

$$\frac{\partial^2 \mathcal{L}}{\partial \alpha \partial \beta} = \sum_{i=1}^{k+1} n_i \frac{P_i P_{i,\alpha\beta} - P_{i,\alpha} P_{i,\beta}}{P_i^2}, \qquad (3.8)$$

where

$$P_i = [g_i]^{\beta} - [g_{i-1}]^{\beta}, \qquad i = 1, 2, \dots, k+1,$$

$$\begin{split} P_{i,\alpha} &= \beta \left\{ [g_i]^{\beta-1} g_{i,\alpha} - [g_{i-1}]^{\beta-1} g_{i-1,\alpha} \right\} \,, \\ P_{i,\beta} &= [g_i]^{\beta} \ln g_i - [g_{i-1}]^{\beta} \ln g_{i-1} \,, \\ P_{i,\beta^2} &= [g_i]^{\beta} [\ln g_i]^2 - [g_{i-1}]^{\beta} [\ln g_{i-1}]^2 \,, \\ P_{i,\alpha\beta} &= [g_i]^{\beta-1} g_{i,\alpha} - [g_{i-1}]^{\beta-1} g_{i-1,\alpha} + \beta \left\{ [g_i]^{\beta-1} g_{i,\alpha} \ln g_i - [g_{i-1}]^{\beta-1} g_{i-1,\alpha} \ln g_{i-1} \right\} \,, \\ P_{i,\alpha^2} &= \beta \left\{ (\beta-1) \left[ [g_i]^{\beta-2} g_{i,\alpha}^2 - [g_{i-1}]^{\beta-2} g_{i-1,\alpha}^2 \right] + [g_i]^{\beta-1} g_{i,\alpha^2} - [g_{i-1}]^{\beta-1} g_{i-1,\alpha^2} \right\} \,, \\ g_i &= g(t_i;\alpha) = 1 - e^{-\alpha t_i} \,, \ i = 1, 2, \dots, k, \ g_{k+1} = 1, \ g_0 = 0 \,, \\ g_{i,\alpha} &= t_i \, e^{-\alpha t_i} \,, \quad g_{i,\alpha^2} = -t_i^2 \, e^{-\alpha t_i} \,. \end{split}$$

Therefore, the approximate  $100(1-\gamma)\%$  two sided confidence intervals for  $\alpha$  and  $\beta$  are, respectively, given by

$$\hat{\alpha} \pm Z_{\gamma/2} \sqrt{\mathbf{I}_{11}^{-1}(\hat{\alpha})} \,, \qquad \hat{\beta} \pm Z_{\gamma/2} \sqrt{\mathbf{I}_{22}^{-1}(\hat{\beta})}$$

Here,  $Z_{\gamma/2}$  is the upper  $(\gamma/2)$ th percentile of a standard normal distribution.

#### 4. GOODNESS OF FIT

The problem of testing goodness-of-fit of an exponential distribution model against the unrestricted class of alternative is complex. However, by restricting the alternative to a generalized exponential distribution, we can use the usual likelihood

ratio test statistic, see (1973), to test the adequacy of an exponential distribution. The following are the null and the alternative hypotheses, respectively,

 $H_0$ :  $\beta = 1$ , exponential distribution,

 $H_1$ :  $\beta \neq 1$ , generalized exponential distribution.

In terms of the MLE, the likelihood ration test statistic for testing  $H_0$  against  $H_1$  is

$$\Lambda = \frac{L(\alpha, \beta = 1)}{L(\alpha, \beta)}.$$
(4.1)

Under the null hypothesis,  $X_L = -2 \ln(\Lambda) = 2(\mathcal{L}_{GE} - \mathcal{L}_E)$  follows a  $\chi^2$  distribution with 1 degree of freedom. Here  $\mathcal{L}_E$  and  $\mathcal{L}_{GE}$  are the log-likelihood functions under  $H_0$  and  $H_1$ , respectively, after replacing the unknown parameters with their MLE.

## 5. DATA ANALYSIS

Using the set of real data presented in Nelson (1982), which is a set of cracking data on 167 independent and identically parts in a machine. The test duration was 63.48 months and 8 unequally spaced inspections were conducted to obtain the number of cracking parts in each interval. The data were

$$(t_1, \dots, t_8) = (6.12, 19.92, 29.64, 35.40, 39.72, 45.24, 52.32, 63.48)$$

and

$$(x_1, \dots, x_8) = (5, 16, 12, 18, 18, 2, 6, 17, 73)$$

Assuming the ED( $\alpha$ ) (or under  $H_0$ :  $\beta = 1$ ), the MLE of  $\alpha$  and MTTF are obtained as

$$\hat{\alpha} = 1.2097 \times 10^{-2}, \qquad \widehat{\text{MTTF}} = 82.6655.$$

The corresponding log-likelihood function is  $\mathcal{L}_E = -316.6705$ .

Assuming the  $GED(\alpha, \beta)$ , the MLE of the parameters  $\alpha$  and  $\beta$  are obtained as

$$\hat{\alpha} = 2.0285 \times 10^{-2}$$
, and  $\hat{\beta} = 1.7839$ 

The corresponding log-likelihood function is  $\mathcal{L}_{GED} = -309.74$ .

Therefore, the likelihood ratio test statistic is  $X_L = 2(\mathcal{L}_{GED} - \mathcal{L}_{ED}) = 13.8592$  and the *p*-value is  $1.9708 \times 10^{-4}$ . Thus the GED(2.0285 ×  $10^{-2}$ , 1.7839) fits this data much better than ED(1.2097 ×  $10^{-2}$ ).

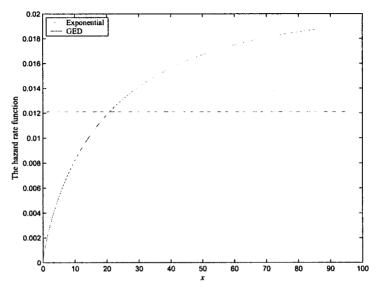


Figure 5.1. The estimated hazard rate functions.

The variance covariance matrix is computed as

$$I^{-1} = \begin{bmatrix} 8.1226 \times 10^{-6} & 6.5626 \times 10^{-4} \\ 6.5626 \times 10^{-4} & 7.3470 \times 10^{-2} \end{bmatrix}$$

Thus, the variances of the MLE of  $\alpha$  and  $\beta$  become  $\text{Var}(\hat{\alpha}) = 8.1226 \times 10^{-6}$  and  $\text{Var}(\hat{\beta}) = 7.3470 \times 10^{-2}$ . Therefore, the 95% C.I of  $\alpha$  and  $\beta$ , respectively, are

$$\left[1.4699 \times 10^{-2}, \ 2.5871 \times 10^{-2}\right], \ \ [1.2526, \ 2.3151].$$

Figure 5.1 shows the hazard rate functions of the  $ED(\alpha)$  and  $GED(\alpha, \beta)$  computed when the MLE of the parameters replacing the unknown parameters.

Figure 5.2 shows the empirical estimate of survival function and estimation of survival function under  $H_0$  and  $H_1$ . Also, we computed the Kolmogorov-Smirnov (K-S) distances of the empirical distribution function and the fitted distribution for the data set. The K-S distance between the empirical survival function and the fitted exponential survival function is 0.0547. The K-S distance between the empirical survival function and the fitted generalized exponential survival function is 0.0298.

Based on the 95% C.I of  $\beta$  and the values of the K-S distances, we get the same conclusion that the values of the likelihood ration test statistics and p-value which leads to that the GED(2.0285 × 10<sup>-2</sup>, 1.7839) fits this data rather than the ED(1.2097 × 10<sup>-2</sup>).

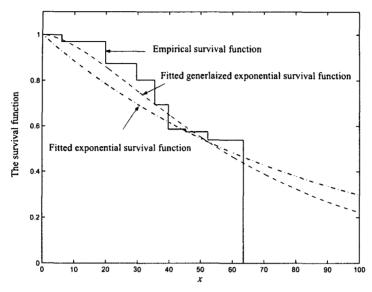


Figure 5.2. The empirical and fitted survival functions.

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